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|-----------------------------------|--|-------------------------|---|--|
| Notice of References Cited | | Application/Control No. | Applicant(s)/Patent Under Reexamination | |
| | | 10/542,780 | TAKI, TETSUYA | |
| Examiner David Goodwin | | Art Unit 2818 | Page 1 of 1 | |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|---------------------|----------------|
| * | A | US-2006/0017061 | 01-2006 | Sakamoto et al. | 257/103 |
| * | B | US-2005/0269584 | 12-2005 | Hasegawa et al. | 257/094 |
| * | C | US-2005/0205881 | 09-2005 | Yamazoe et al. | 257/085 |
| * | D | US-6,242,764 | 06-2001 | Ohba et al. | 257/190 |
| * | E | US-2005/0145860 | 07-2005 | Tanizawa, Koji | 257/085 |
| * | F | US-2002/0190263 | 12-2002 | Hata et al. | 257/103 |
| * | G | US-2002/0104997 | 08-2002 | Kuo et al. | 257/79 |
| * | H | US-6,064,079 | 05-2000 | Yamamoto et al. | 257/101 |
| * | I | US-6,686,608 | 02-2004 | Takahira, Yoshiyuki | 257/96 |
| * | J | US-6,841,800 | 01-2005 | Oku et al. | 257/94 |
| * | K | US-5,970,080 | 10-1999 | Hata, Toshio | 372/45.01 |
| * | L | US-2002/0014632 | 02-2002 | Kaneyama et al. | 257/103 |
| * | M | US-6,872,986 | 03-2005 | Fukuda et al. | 257/101 |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| | | |
|---|---|---|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | W | |
| | X | |

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Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.